

<b>Notice of References Cited</b>	Application/Control No. 10/561,840		Applicant(s)/Patent Under Reexamination MIYAIRI ET AL.	
	Examiner BRYAN D. RIPA		Art Unit 1795	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0134666	09-2002	Hemingway et al.	204/164
*	B	US-2002/0131918	09-2002	Nelson et al.	422/186.04
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001193441 A	07-2001	Japan	ARAKAWA, MIYAO	
	O	WO 02074435 A1	09-2002	World Intellect	CARLOW J S et al.	
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Machine Translation of JP 2001-193441 A
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.